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## IN THE SNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT:

Spooner at al.

GROUP:

2811

**SERIAL NO:** 

10/006,964

**EXAMINER:** 

T. Dickey

FILED:

12/05/2001

FOR: METHOD AND DEVICE FOR PROTECTING MICRO ELECTROMECHANICAL

SYSTEMS STRUCTURES DURING DICING OF A WAFER

Assistant Commissioner of Patents Washington, D.C. 20231 Sir:

# **INFORMATION DISCLOSURE STATEMENT**

In compliance with 37 C.F.R. §§1.56, 1.97, and 1.98, Applicant submits copies of the documents listed on the attached Form PTO-1449.

The listed documents were recently cited in a corresponding PCT application, and a copy of the International Search Report is being submitted herewith for purposes of convenience.

The Commissioner is authorized to charge Deposit Order Account No. 19-0079 for any further fee that is required.

Respectfully submitted,

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I hereby certify that this paper (along with any paper referred to as being attached or enclosed) is being deposited with the United States Postal Service on the date shown below with sufficient postage as first class mail in an envelope addressed to the Commissioner of Patents and Trademarks, Washington, D.C. 20231.

10/30/2002

(Rev. 5/92)

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> INFORMATION DISCLOSURE STATEMENT BY APPLICANT

5721-3

ATTORNEY DOCKET NO.

Spooner et al. **APPLICANT** 

12/05/2001 FILING DATE

10/006,964 SERIAL NO.

<u>2811</u> GROUP

<u>UNKNOWN</u> **EXAMINER** 

#### U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	5,824,177	10/20/1998	Yoshihara et al.			07/12/1996
	AB	6,106,735	08/22/2000	Kurle et al.			01/12/1998
	AC	5,610,431	03/11/1997	Martin			05/12/1995
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	AI						<b></b>

### FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	-	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AJ	08250454	09/27/1996	JP			YES (Abstract Only)
	AK	100 13 067 A1	09/21/2000	DE			NO
	AL	199 11 916 A1	09/23/1999	DE			NO
	AM						
	AN						

### OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL		
	AO	
	AP	

**EXAMINER** 

DATE CONSIDERED

**EXAMINER:** 

Initial if citation considered, whether rn t citati n is in c nformanc with MPEP 609; draw lin through citation if n t in c nformanc and not considered. Include copy of this form with next communication t applicant.